

Notice of References Cited

Application/Control No.

10/668,360

Applicant(s)/Patent Under
Reexamination
OHYAMA ET AL.

Examiner

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Art Unit

2625

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,005,673 A	12-1999	Murai et al.	358/434
*	B	US-6,069,706 A	05-2000	Kajita et al.	358/1.15
*	C	US-2002/0080250 A1	06-2002	OGAWA et al.	348/232
*	D	US-2002/0156923 A1	10-2002	Tanimoto, Yoshifumi	709/246
*	E	US-2002/0141380 A1	10-2002	Koguchi, Masatsugu	370/351
*	F	US-2002/0149784 A1	10-2002	Levin et al.	358/1.2
*	G	US-2004/0233484 A1	11-2004	Seko et al.	358/523
*	H	US-7,352,488 B2	04-2008	Ben-Chorin et al.	358/1.9
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	X					

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